

Search Notes



Application/Control No.

10/809,928

Examiner

Rip A. Lee

Applicant(s)/Patent under Reexamination

ISEKI ET AL.

Art Unit

1713

SEARCHED

Class	Subclass	Date	Examiner
526	348.6	0624-205M	
526	348.2		
526	348		
528	396		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST text search	0624-205M	
EAST/PRISM intro to 0624-205M		